

<b>Notice of References Cited</b>		Application/Control No.	Applicant(s)/Patent Under Reexamination NAKANO ET AL.	
		Examiner Thomas W. Irvin	Art Unit 3683	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-3,168,836 A	02-1965	MILITANA FRANK A	474/152
*	B	US-5,480,357 A	01-1996	Liang, Tzong T.	474/77
*	C	US-5,733,215 A	03-1998	Hsu et al.	474/160
*	D	US-5,860,882 A	01-1999	Petrilli et al.	474/158
*	E	US-5,947,265 A	09-1999	Merten et al.	198/834
*	F	US-5,980,406 A	11-1999	Mott et al.	474/84
*	G	US-2001/0039224 A1	11-2001	Lim et al.	474/160
*	H	US-2002/0002092 A1	01-2002	Reguzzi, Luigi	474/152
*	I	US-6,428,437 B1	08-2002	Schlanger, Raphael	474/160
*	J	US-2003/0171180 A1	09-2003	Shahana et al.	474/152
*	K	US-2004/0142782 A1	07-2004	Kamada et al.	474/160
*	L	US-2004/0142783 A1	07-2004	Kamada et al.	474/160
*	M	US-2005/0009654 A1	01-2005	Kanehisa et al.	474/152

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

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